

# MOS FIELD EFFECT TRANSISTOR $\mu$ PA2701TP

# SWITCHING N-CHANNEL POWER MOS FET

# DESCRIPTION

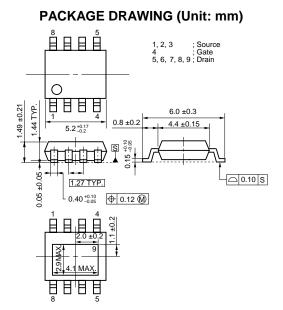
The  $\mu$ PA2701TP, which has a heat spreader, is N-Channel MOS Field Effect Transistor designed for DC/DC converter and power management applications of notebook computers.

# FEATURES

- Low on-state resistance  $R_{DS(on)1} = 7.5 \text{ m}\Omega \text{ MAX.}$  (Vgs = 10 V, ID = 7.0 A)  $R_{DS(on)2} = 11.6 \text{ m}\Omega \text{ MAX.}$  (Vgs = 4.5 V, ID = 7.0 A)
- Low Ciss: Ciss = 1200 pF TYP. (VDS = 10 V, VGS = 0 V)
- Small and surface mount package (Power HSOP8)

# **ORDERING INFORMATION**

PART NUMBER	PACKAGE
μΡΑ2701TP	Power HSOP8



# ABSOLUTE MAXIMUM RATINGS (TA = 25°C, Unless otherwise noted, All terminals are connected.)

Drain to Source Voltage (Vgs = 0 V)	VDSS	30	V	
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V	EQUIVALENT CIRCUIT
Drain Current (DC) (Tc = 25°C)	D(DC)1	±35	А	
Drain Current (DC) (T <sub>A</sub> = 25°C) Note1	D(DC)2	±16	А	Drain ♀
Drain Current (pulse) <sup>Note2</sup>	D(pulse)	±80	А	Body
Total Power Dissipation (Tc = 25°C)	<b>P</b> T1	28	W	Gate Diode
Total Power Dissipation $(T_A = 25^{\circ}C)^{Note1}$	Рт2	3	W	
Channel Temperature	Tch	150	°C	Gate
Storage Temperature	Tstg	–55 to +150	°C	Protection Source Diode
Single Avalanche Current Note3	AS	18	А	
Single Avalanche Energy Note3	Eas	32.4	mJ	

Notes 1. Mounted on a glass epoxy board (1 inch x 1 inch x 0.8 mm), PW = 10 sec

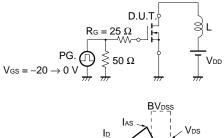
- **2.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%
- 3. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 15 V, R<sub>G</sub> = 25  $\Omega$ , L = 100  $\mu$ H, V<sub>GS</sub> = 20  $\rightarrow$  0 V
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

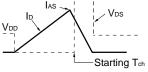
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# ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C, Unless otherwise noted, All terminals are connected.)

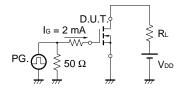
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNI
Zero Gate Voltage Drain Current	DSS	VDS = 30 V, VGS = 0 V			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A	7	14		S
Drain to Source On-state Resistance	RDS(on)1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.0 A		6.2	7.5	m۵
	RDS(on)2	Vgs = 4.5 V, Id = 7.0 A		8.7	11.6	m۵
	RDS(on)3	Vgs = 4.0 V, Id = 7.0 A		10.3	13.7	m۵
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		1200		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		500		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		160		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 7.0 A		10		ns
Rise Time	tr	V <sub>GS</sub> = 10 V		13		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 10 Ω		44		ns
Fall Time	tr			11		ns
Total Gate Charge	QG	V <sub>DD</sub> = 15 V		12		nC
Gate to Source Charge	QGS	V <sub>GS</sub> = 5 V		4		nC
Gate to Drain Charge	Qgd	ID = 14 A		6		nC
Body Diode Forward Voltage	VF(S-D)	IF = 14 A, VGS = 0 V		0.8	1.2	V
Reverse Recovery Time	trr	IF = 14 A, VGS = 0 V		32		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		27		nC

## TEST CIRCUIT 1 AVALANCHE CAPABILITY

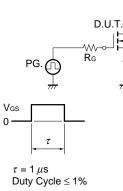


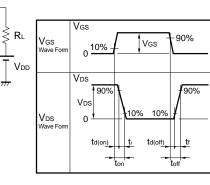


### TEST CIRCUIT 3 GATE CHARGE

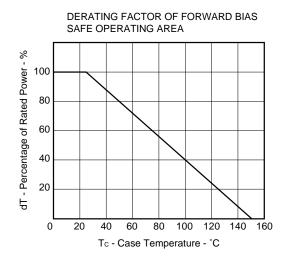


### **TEST CIRCUIT 2 SWITCHING TIME**

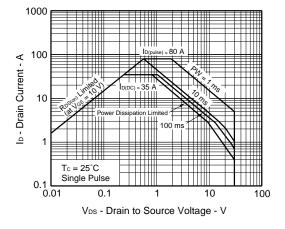


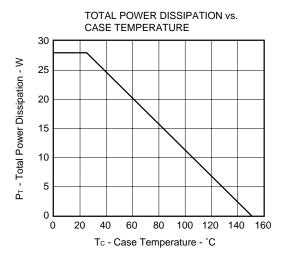


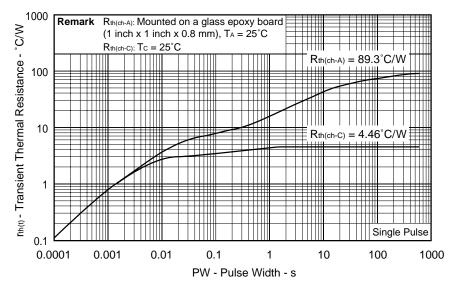
# TYPICAL CHARACTERISTICS ( $T_A = 25^{\circ}C$ )





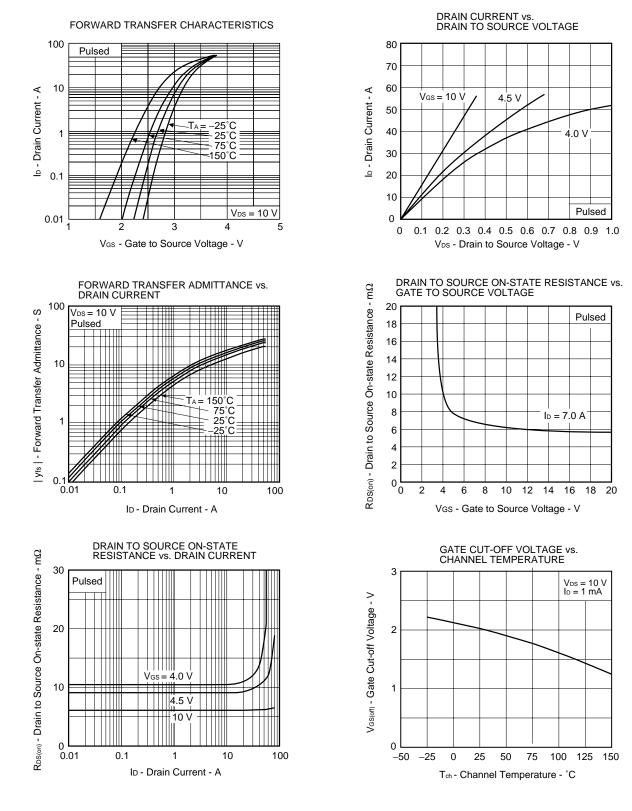




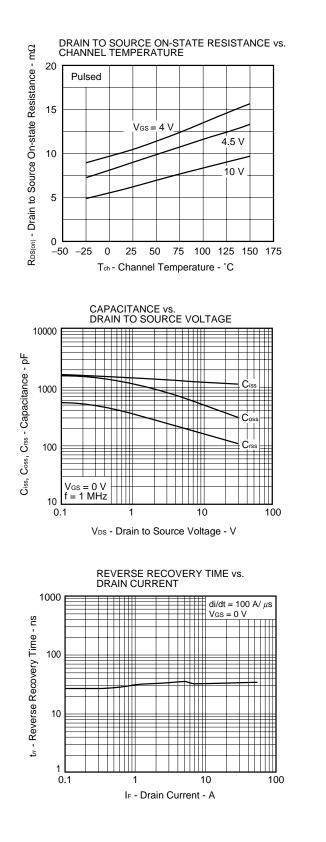


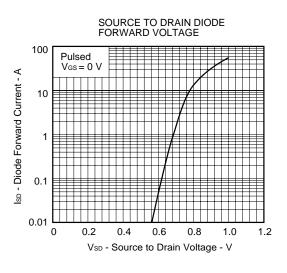
### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

Data Sheet G15844EJ2V0DS

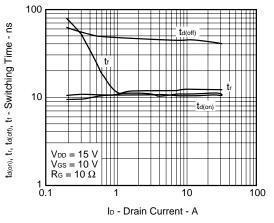


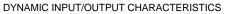
NEC

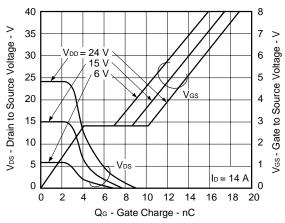




SWITCHING CHARACTERISTICS







[MEMO]

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